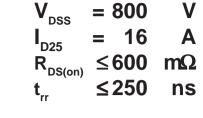


PolarHV[™] Power MOSFET

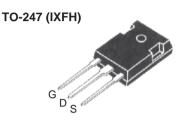
N-Channel Enhancement Mode Fast Recovery Diode Avalanche Rated IXFH 16N80P IXFT 16N80P IXFV 16N80PS





		å S			
Symbol	Test Conditions	Maximum	Maximum Ratings		
V _{DSS}	$T_J = 25^{\circ}C$ to $150^{\circ}C$	800	V		
\mathbf{V}_{DGR}	$T_J = 25^{\circ}C$ to 150°C; $R_{GS} = 1 \text{ M}\Omega$	800	V		
V _{GSS}	Continuous	±30	V		
V _{GSM}	Transient	±40	V		
I _{D25}	T _C = 25°C	16	А		
I _{DM}	$T_{\rm C} = 25^{\circ}{\rm C}$, pulse width limited by $T_{\rm JM}$	40	Α		
I _{AR}	T _C = 25°C	8	А		
E _{AR}	$T_{c} = 25^{\circ}C$	30	mJ		
E _{AS}	$T_c = 25^{\circ}C$	1.0	J		
dv/dt	$I_{S} \le I_{DM}, di/dt \le 100 A/\mu s, V_{DD} \le V_{DSS}$ $T_{J} \le 150$ °C, $R_{G} = 5 \Omega$	10	V/ns		
P _D	T _c = 25°C	460	W		
T _J		-55 +150 150	°C		
T _{JM} T _{stg}		-55 +150	°C		
T _L T _{SOLD}	1.6 mm (0.062 in.) from case for 10 s Plastic body for 10 s	300 260	°C		
M _d	Mounting torque (TO-247)	1.13/10	Nm/lb.in.		
F _c	Mounting force (PLUS220)	1165/2.515	N/lb		
Weight	TO-247 TO-268 PLUS220 & PLUS220SMD	6.0 5.0 4.0	g g		

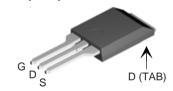
Symbol (T _J = 25°C, u	Test Conditions unless otherwise specified)			aracter Typ.	istic Val Max.	
BV _{DSS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		800			V
V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 4 \text{ mA}$		3.0		5.0	V
GSS	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$				±100	nA
l _{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 V$	T _J = 125°C			25 250	μΑ μΑ
R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_{D} = 0.5 I_{D25}$ Pulse test, $t \le 300 \mu\text{s}$, duty c	ycle d≤2%			600	mΩ



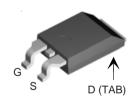
TO-268 (IXFT)



PLUS220 (IXFV)



PLUS220SMD (IXFV...S)



G = Gate S = Source D = Drain TAB = Drain

Features

- Fast Recovery diode
- Unclamped Inductive Switching (UIS)
 rated
- International standard packages
- Low package inductance
 - easy to drive and to protect

Advantages

- Easy to mount
- Space savings
- High power density



Symbo	Symbol Test Conditions Characterist $(T_J = 25^{\circ}C, \text{ unless otherwise})$				
			Min.	Тур.	Max.
\mathbf{g}_{fs}		$V_{DS} = 20 \text{ V}; I_{D} = 0.5 I_{D25}, \text{ pulse}$	e test 9	16	S
\mathbf{C}_{iss})			4600	pF
\mathbf{C}_{oss}	}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ N}$	ИHz	330	pF
C _{rss}	J			23	pF
$\mathbf{t}_{d(on)}$)			27	ns
t _r		$V_{GS} = 10 \text{ V}, V_{DS} = V_{DSS}, I_{D} = 0.8$	5 I _{D25}	32	ns
$\mathbf{t}_{d(off)}$	1	$R_G = 5 \Omega \text{ (External)}$		75	ns
t _f	J			29	ns
$\mathbf{Q}_{\mathrm{g(on)}}$)			71	nC
\mathbf{Q}_{gs}	}	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 \text{ V}_{DSS}, I_{D}$	= 0.5 I _{D25}	21	nC
\mathbf{Q}_{gd}	J			23	nC
R_{thJC}					0.27 °C/W
$R_{\scriptscriptstyle thCS}$		(TO-247)		0.21	°C/W

Source-Drain Diode

Characteristic Values (T. = 25°C, unless otherwise specified)

Symbo	I Test Conditions	Min.	Тур.	Max.	
Is	$V_{GS} = 0 V$			16	Α
I _{sm}	Repetitive			48	Α
V _{SD}	$I_F = I_S$, $V_{GS} = 0$ V, pulse test			1.5	V
t _{rr}	$I_F = 25A$, -di/dt = 100 A/ μ s		150	250	ns
I _{RM}	$V_{R} = 100V; V_{GS} = 0 V$		7		Α
\mathbf{Q}_{RM}	J		0.7		μС

Fig. 1. Output Characteristics @ 25°C

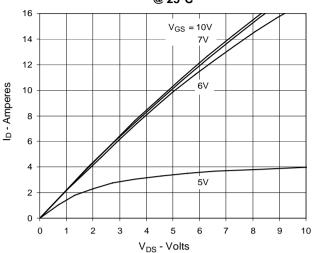


Fig. 2. Extended Output Characteristics @ 25°C

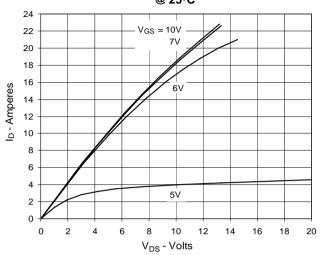


Fig. 3. Output Characteristics @ 125°C

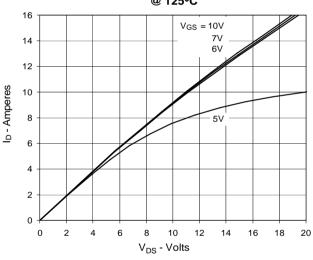


Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 8A$ Value vs. Junction Temperature

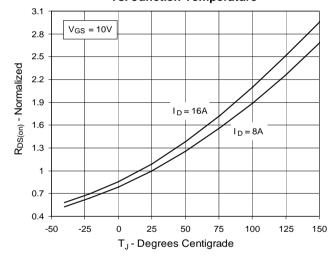


Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 8A$ Value vs. Drain Current

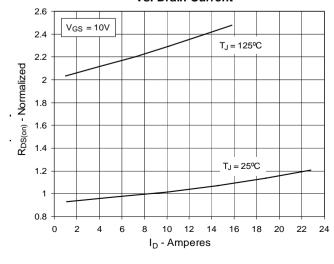
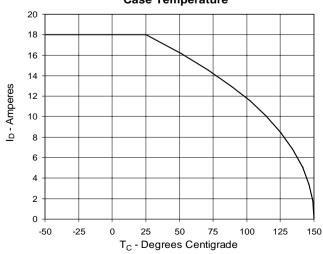


Fig. 6. Maximum Drain Current vs.

Case Temperature



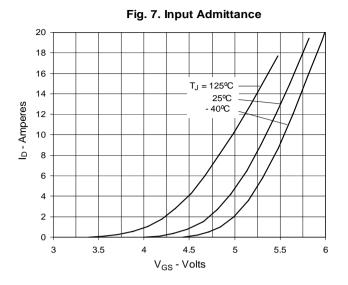
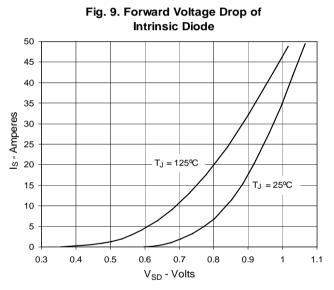
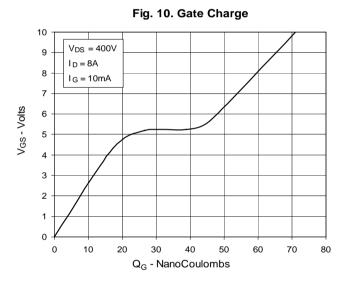
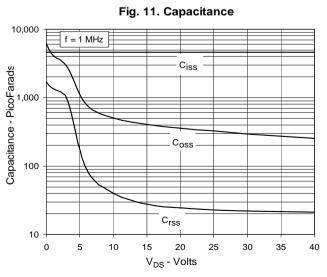
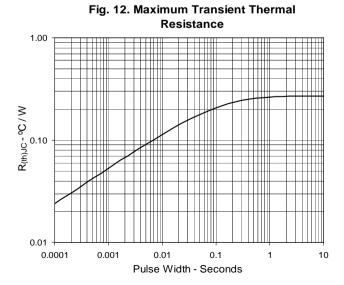


Fig. 8. Transconductance T_J = - 40°C gfs - Siemens 25°C 125℃ I_D - Amperes





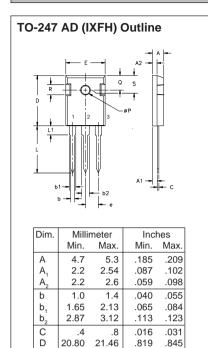




IXYS reserves the right to change limits, test conditions, and dimensions.



IXFH 26N60P IXFT 26N60P IXFV 26N60PS



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S

15 75

5.20

19.81

3 55

5.89

4.32

6.15 BSC

16.26

5.72

20.32

4.50

3.65

6.40

5.49

610

.780

140

.170

0.205 0.225

0.232 0.252

242 BSC

640

800

.177

144

.216

